

SCDS197C-DECEMBER 2005-REVISED APRIL 2006

TQFN PACKAGE

(TOP VIEW)

FEATURES

- Compatible With HDMI v1.2a (Type A) DVI 1.0 High-Speed Digital Interface
 - Wide Bandwidth of Over 1.65 Gbps (Bandwidth 2.4 Gbps Typ)
 - 165-MHz Speed Operation
 - Serial Data Stream at 10× Pixel Clock Rate
 - Supports All Video Formats up to 1080p and SXGA (1280 \times 1024 at 75 Hz)
 - Total Raw Capacity 4.95 Gbps (Single Link)
 - HDCP Compatible
- Low Crosstalk (X_{TALK} = -41 dB Typ)
- Low Bit-to-Bit Skew (t_{sk(o)} = 0.1 ns Max)
- Low and Flat ON-State Resistance $(r_{on} = 6 \Omega \text{ Max}, r_{on(flat)} = 0.5 \Omega \text{ Typ})$
- Low Input/Output Capacitance (C_{ON} = 7.8 pF Typ)
- Rail-to-Rail Switching on Data I/O Ports (0 to 5 V)
- V_{CC} Operating Range From 3 V to 3.6 V
- I_{off} Supports Partial-Power-Down Mode Operation
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Performance Tested Per JESD 22
 - 2000-V Human-Body Model (A114-B, Class II)
 - 1000-V Charged-Device Model (C101)

APPLICATIONS

- DVI/HDMI Signal Switching
- Differential DVI, HDMI Signal Multiplexing for Audio/Video Receivers and High-Definition Televisions (HDTVs)

DESCRIPTION/ORDERING INFORMATION

The TS3DV520 is a 20-bit to 10-bit multiplexer/demultiplexer digital video switch with a single select (SEL) input. SEL controls the data path of the multiplexer/demultiplexer. The device provides five differential channels for digital video signal switching.

This device provides low and flat ON-state resistance (r_{on}) and excellent ON-state resistance match. Low input/output capacitance, high bandwidth, low skew, and low crosstalk among channels make this device suitable for various digital video applications, such as DVI and HDMI.

This device is fully specified for partial-power-down applications using I_{off} . The I_{off} feature ensures that damaging current will not backflow through the device when it is powered down. The device has isolation during power off.

0B₁ **GND** 1 48 A_0 1B₁ 2 47 A_1 3 46 0B₂ 45 $1B_2$ 4 V_{CC} 5 **GND** NC 44 **GND** 6 43 2B₁ 3B₁ A_2 7 42 2B₂ 8 41 A_3 40 3B₂ **GND** 9 39 **GND** 10 V_{CC} 11 38 V_{CC} A_5 4B₁ 37 5B₁ **GND** 13 36 35 $4B_2$ 5B₂ 34 GND GND 16 33 6B₁ SEL 17 32 7B₁ 31 18 V_{CC} A₈ 19 30 6B₂ 29 7B₂ 20 A₉

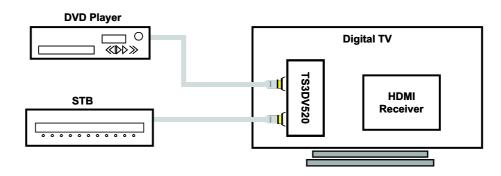
NC - No internal connection



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.







ORDERING INFORMATION

T _A	PACKAGE ⁽¹⁾		ORDERABLE PART NUMBER	TOP-SIDE MARKING
-40°C to 85°C	TQFN	Tape and reel	TS3DV520RHUR	SD520

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

FUNCTION TABLE

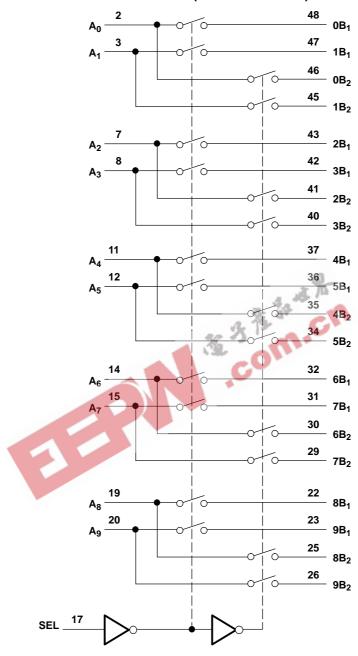
INPUT SEL	INPUT/OUTPUT An	FUNCTION					
L	nB ₁	$A_n = nB_1$	nB ₂ high-impedance mode				
Н	nB ₂	$A_n = nB_2$	nB ₁ high-impedance mode				

PIN DESCRIPTION

_	NAME	DESCRIPTION
	A _n	Data I/O
	nB _m	Data I/O
	SEL	Select input

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LOGIC DIAGRAM (POSITIVE LOGIC)





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Absolute Maximum Ratings⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V_{CC}	Supply voltage range		-0.5	4.6	V
V _{IN}	Control input voltage range ⁽²⁾⁽³⁾		-0.5	7	V
V _{I/O}	Switch I/O voltage range (2)(3)(4)		-0.5	7	V
I_{IK}	Control input clamp current	V _{IN} < 0		-50	mA
I _{I/OK}	I/O port clamp current	V _{I/O} < 0		-50	mA
I _{I/O}	ON-state switch current ⁽⁵⁾			±128	mA
	Continuous current through V _{CC} or GND			±100	mA
θ_{JA}	Package thermal impedance (6)			31.8	°C/W
T _{stg}	Storage temperature range		-65	150	°C

- (1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltages are with respect to ground, unless otherwise specified.
- (3) The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
- (4) V_I and V_O are used to denote specific conditions for V_{I/O}.
- (5) $I_{\rm I}$ and $I_{\rm O}$ are used to denote specific conditions for $I_{\rm I/O}$.
- (6) The package thermal impedance is calculated in accordance with JESD 51-7.

Recommended Operating Conditions(1)

		MIN	MAX	UNIT
V_{CC}	Supply voltage	3	3.6	V
V_{IH}	High-level control input voltage (SEL)	2	5.5	V
V_{IL}	Low-level control input voltage (SEL)	0	8.0	V
V _{I/O}	Input/output voltage	0	5.5	V
T_A	Operating free-air temperature	-40	85	°C

⁽¹⁾ All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.



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Electrical Characteristics (1)

for high-frequency switching over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted)

PARAMETER			TEST CO	NDITIONS		MIN	TYP ⁽²⁾	MAX	UNIT
V_{IK}	SEL	$V_{CC} = 3.6 \text{ V},$	$I_{IN} = -18 \text{ mA}$				-0.7	-1.2	V
I _{IH}	SEL	$V_{CC} = 3.6 \text{ V},$	$V_{IN} = V_{CC}$					±1	μΑ
I _{IL}	SEL	$V_{CC} = 3.6 \text{ V},$	V _{IN} = GND					±1	μΑ
I _{off}		V _{CC} = 0,	$V_0 = 0 \text{ to } 3.6 \text{ V},$	V _I = 0				1	μΑ
I_{CC}		$V_{CC} = 3.6 \text{ V},$	$I_{I/O}=0,$	Switch ON or OFF			250	500	μΑ
C _{IN}	SEL	f = 1 MHz,	$V_{IN} = 0$				2	2.5	pF
C _{OFF}	B port	$V_I = 0$,	f = 1 MHz,	Outputs open,	Switch OFF		2.5	3	pF
C _{ON}		$V_I = 0$,	f = 1 MHz,	Outputs open,	Switch ON		7.8	8.5	pF
r _{on}		V _{CC} = 3 V,	$1.5 \text{ V} \leq \text{V}_{\text{I}} \leq \text{V}_{\text{CC}},$	I _O = -40 mA			3.5	6	Ω
r _{on(flat)} (3)		V _{CC} = 3 V,	$V_I = 1.5 \text{ V} \text{ and } V_{CC},$	I _O = -40 mA			0.5		Ω
$\Delta r_{on}^{(4)}$		V _{CC} = 3 V,	$1.5 \text{ V} \leq \text{V}_{\text{I}} \leq \text{V}_{\text{CC}},$	I _O = -40 mA			0.4	1	Ω

- $\begin{array}{lll} \text{(1)} & V_{\text{I}}, \, V_{\text{O}}, \, I_{\text{I}}, \, \text{and} \, I_{\text{O}} \, \, \text{refer to I/O pins.} \, \, V_{\text{IN}} \, \, \text{refers to the control inputs.} \\ \text{(2)} & \, \text{All typical values are at V}_{\text{CC}} = 3.3 \, \, \text{V} \, \, \text{(unless otherwise noted)}, \, T_{\text{A}} = 25^{\circ}\text{C}. \\ \text{(3)} & \, r_{\text{on}(\text{flat})} \, \, \text{is the difference of r}_{\text{on}} \, \, \text{in a given channel at specified voltages.} \\ \text{(4)} & \, \Delta r_{\text{on}} \, \, \text{is the difference of r}_{\text{on}} \, \, \text{from center} \, \, \, \text{(A}_{4}, \, A_{5}) \, \, \text{ports to any other port.} \\ \end{array}$

 (3) r_{on(flat)} is the difference of r_{on} in a given channel at specified voltages.
 (4) Δr_{on} is the difference of r_{on} from center (A₄, A₅) ports to any other port.
 Switching Characteristics
 over recommended operating free-air temperature range, V_{CC} = 3.3 V ± 0.3 V, R_L = 200 Ω, C_L = 10 pF (unless otherwise noted) (see Figure 4 and Figure 5)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	TYP ⁽¹⁾	MAX	UNIT
t _{pd} ⁽²⁾	A or B	B or A		0.25		ns
t _{PZH} , t _{PZL}	SEL	A or B	0.5		15	ns
t _{PHZ} , t _{PLZ}	SEL	A or B	0.5		9	ns
t _{sk(o)} (3)	A or B	B or A		0.05	0.1	ns
t _{sk(p)} (4)				0.05	0.1	ns

- (1) All typical values are at $V_{CC} = 3.3 \text{ V}$ (unless otherwise noted), $T_A = 25^{\circ}C$.
- The propagation delay is the calculated RC time constant of the typical ON-state resistance of the switch and the specified load capacitance when driven by an ideal voltage source (zero output impedance).
- Output skew between center port (A₄ to A₅) to any other port
- (4) Skew between opposite transitions of the same output in a given device |t_{PHL} t_{PLH}|

Dynamic Characteristics

over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted)

PARAMETER		TEST CONDITIONS					
X _{TALK}	$R_L = 100 \Omega$,	f = 250 MHz,	See Figure 7	-41	dB		
O _{IRR}	$R_L = 100 \Omega$,	f = 250 MHz,	See Figure 8	-39	dB		
BW	$R_L = 100 \Omega$,	See Figure 6		1.2	GHz		

(1) All typical values are at V_{CC} = 3.3 V (unless otherwise noted), T_A = 25°C.

-60

-80

-100

0.1

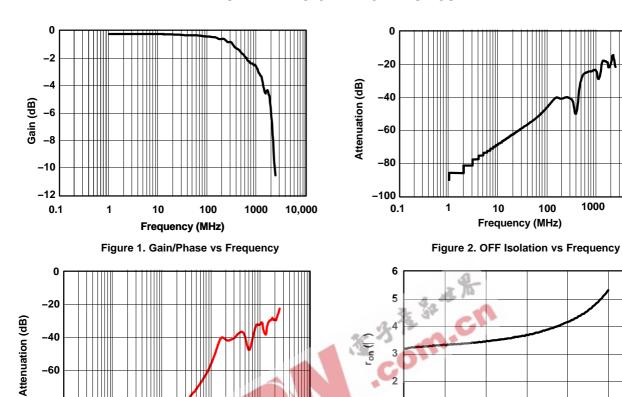


1000

100

10,000

OPERATING CHARACTERISTICS



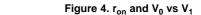
1000

100

Frequency (MHz)

Figure 3. Crosstalk vs Frequency

10,000



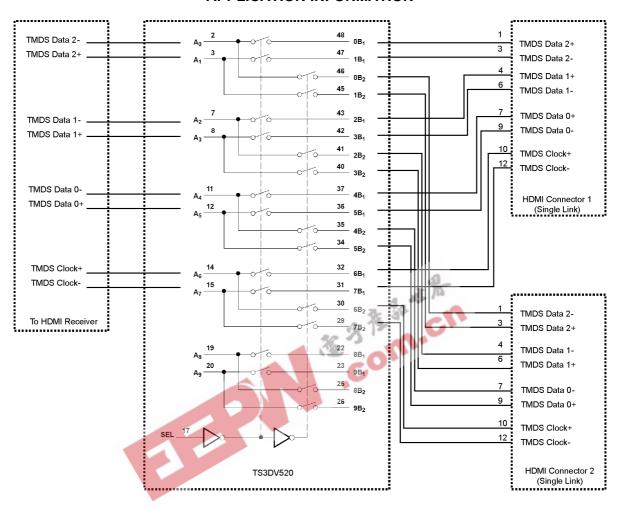
V_{COM} (V)

0

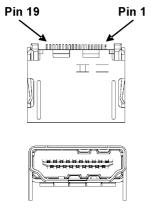
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APPLICATION INFORMATION



Typical HDMI Connector

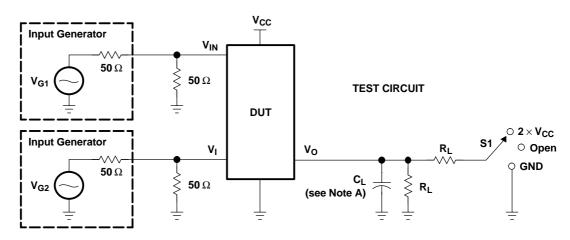


The TS3DV520 can be used to switch between two digital video ports.

Pin	Signal Assignment
1	TMDS Data2+
2	TMDS Data2 Shield
3	TMDS Data 2-
4	TMDS Data1+
5	TMDS Data1 Shield
6	TMDS Data 1-
7	TMDS Data0+
8	TMDS Data0 Shield
თ	TMDS Data 0-
10	TMDS Clock+
11	TMDS Clock Shield
12	TMDS Clock-
13	CEC
14	Reserved (N.C. on device)
15	SCL
16	SDA
17	DDC/CEC Ground
18	+5V Power
19	Hot Plug Detect

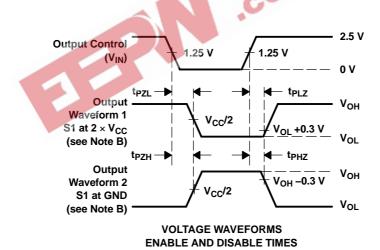


PARAMETER MEASUREMENT INFORMATION (Enable and Disable Times)



					No. of the last of	
TEST	V _{CC}	S1	R_{L}	V _L	CL	$oldsymbol{V}_\Delta$
t _{PLZ} /t _{PZL}	3.3 V \pm 0.3 V	2×V _{CC}	200 Ω	GND	10 pF	0.3 V
t _{PHZ} /t _{PZH}	3.3 V ± 0.3 V	GND	200 Ω	V _{CC}	10 pF	0.3 V

AS.



NOTES: A. C_L includes probe and jig capacitance.

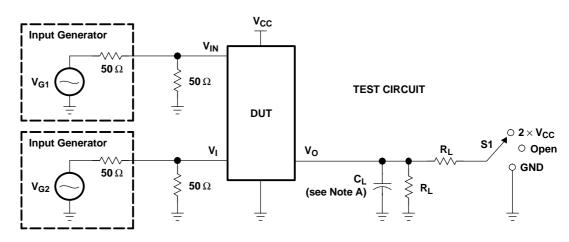
- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_{O} = 50 Ω , $t_{f} \leq$ 2.5 ns, $t_{f} \leq$ 2.5 ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- E. t_{PLZ} and t_{PHZ} are the same as t_{dis}.
- F. t_{PZL} and t_{PZH} are the same as t_{en}.

Figure 5. Test Circuit and Voltage Waveforms

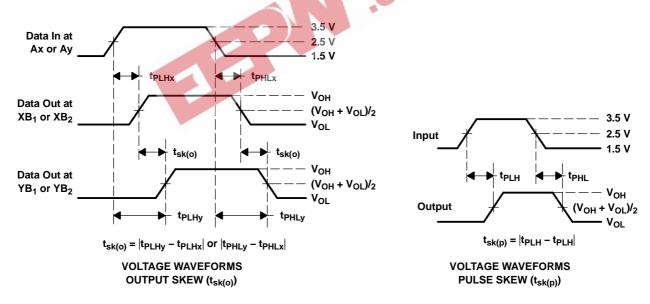
3

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PARAMETER MEASUREMENT INFORMATION (Skew)



TEST	V _{CC}	S1	RL	V _L	CL	${f V}_{\Delta}$
t _{sk(o)}	3.3 V \pm 0.3 V	Open	200 Ω	V _{CC} or GND	10 pF	
t _{sk(p)}	3.3 V ± 0.3 V	Open	200 Ω	V _{CC} or GND	10 pF	



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_O = 50~\Omega$, $t_f \leq$ 2.5 ns, $t_f \leq$ 2.5 ns.
- D. The outputs are measured one at a time, with one transition per measurement.

Figure 6. Test Circuit and Voltage Waveforms



PARAMETER MEASUREMENT INFORMATION

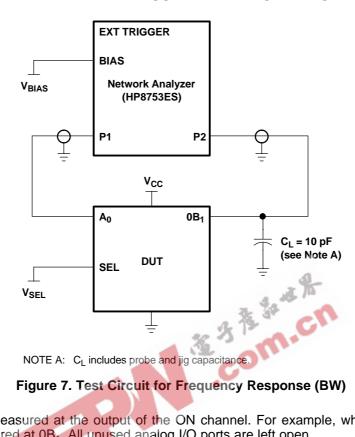


Figure 7. Test Circuit for Frequency Response (BW)

Frequency response is measured at the output of the ON channel. For example, when $V_{SEL}=0$ and A_0 is the input, the output is measured at $0B_1$. All unused analog I/O ports are left open.

HP8753ES setup

Average = 4

RBW = 3 kHz

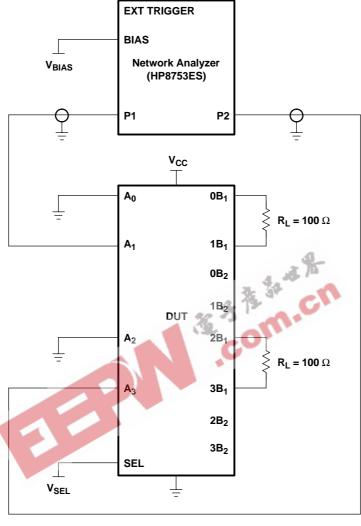
 $V_{BIAS} = 0.35 V$

ST = 2 s

P1 = 0 dBM

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PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

B. A 50- Ω termination resistor is needed to match the loading of the network analyzer.

Figure 8. Test Circuit for Crosstalk (X_{TALK})

Crosstalk is measured at the output of the nonadjacent ON channel. For example, when $V_{SEL}=0$ and A_0 is the input, the output is measured at $1B_1$. All unused analog input (A) ports are connected to GND, and output (B) ports are connected to GND through $50-\Omega$ pulldown resistors.

HP8753ES setup

Average = 4

RBW = 3 kHz

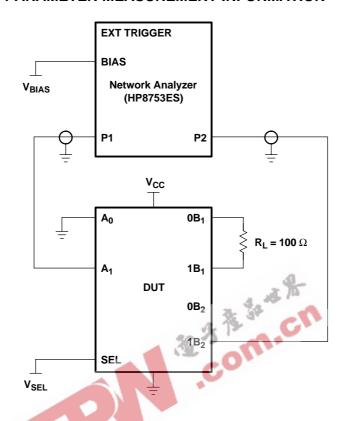
 $V_{BIAS} = 0.35 \text{ V}$

ST = 2 s

P1 = 0 dBM



PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

B. A $50-\Omega$ termination resistor is needed to match the loading of the network analyzer.

Figure 9. Test Circuit for OFF Isolation (OIRR)

OFF isolation is measured at the output of the OFF channel. For example, when $V_{SEL} = V_{CC}$ and A_0 is the input, the output is measured at $0B_2$. All unused analog input (A) ports are left open, and output (B) ports are connected to GND through $50-\Omega$ pulldown resistors.

HP8753ES setup

Average = 4

RBW = 3 kHz

 $V_{BIAS} = 0.35 V$

ST = 2

P1 = 0 dBM



PACKAGE OPTION ADDENDUM

26-Oct-2006

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
TS3DV520ERHUR	ACTIVE	QFN	RHU	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TS3DV520RHUR	ACTIVE	QFN	RHU	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based (lip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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 $-56 \times \frac{0,30}{0,18}$

0,10 M C A B 0,05 (M) C

4206903/A 04/2005

PLASTIC QUAD FLATPACK RHU (R-PQFP-N56) 11,15 A 10,85 В 48 29 49 28 5,15 4.85 Pin 1 Index Area Top And Bottom ◬ 21 0,80 0,20 Nominal 0,70 Lead Frame Seating Plane С 0,00 0,08 C Seating Height 0,50 0,50 Pin 1 Identifier +0,10 3,50 2,40 -0,15

Notes:

Exposed Thermal Pad

A

- All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
- This drawing is subject to change without notice.
- C. QFN (Quad Flatpack No-Lead) package configuration.
- Pin 1 identifiers are located on both top and bottom of the package and within the zone indicated.
- The Pin 1 identifiers are either a molded, marked, or metal feature.

 The package thermal pad must be soldered to the board for thermal and mechanical performance.
- F. JEDEC MO-220 package registration is pending.



8,40 ^{+0,10} -0,15

Bottom View

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